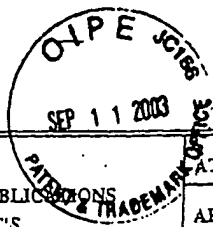




FORM PTO-1449 (Modified)		ATTY DOCKET NO: S63.2-6259-US03		Serial No: 10/600017	
INFORMATION DISCLOSURE STATEMENT BY APPLICANT (Use several sheets if necessary)		APPLICANT: David A. Ferrera et al		FILING DATE: Not Assigned	
Group: Not Assigned					
REFERENCE DESIGNATION U.S. PATENT DOCUMENTS					
EXAM'S INT.		PATENT NUMBER	ISSUE DATE	PATENTEE	CLASS SUBCLASS FILING DATE IF APPROPRIATE
SK	AA	5195969	3/23/93	Wang et al	604 96
	AB	5330428	7/19/94	Wang	604 96
	AC	4154244	5/15/79	Becker	128 349
	AD	5556383	9/17/96	Wang et al	604 96
	AE	5270086	12/14/93	Hamlin	428 35.2
	AF	RE 32,983	7/11/89	Levy	428 36.92
	AG	4963313	10/16/90	Noddin et al.	264 573
	AH	5290306	3/1/94	Trotta et al	606 194
	AI	5512051	4/30/96	Wang et al	604 96
	AJ	5264260	11/23/93	Saab	428 35.5
SK	AK	RE 33,561	3/26/91	Levy	428 36.92
FOREIGN PATENT DOCUMENT OR PUBLISHED FOREIGN PATENT APPLICATION					
		DOCUMENT NUMBER	PUBLICA TION DATE	COUNTRY OF PATENT OFFICE	CLASS SUBCLASS TRANSLATION YES NO
SK	BA	96/04951	2/22/96	WO	A61M 25/00 x
	BB	95/22367	8/24/95	WO	A61M 25/00 x
	BC	0457456	11/21/91	EP	A61M 25/00 x
	BD	92/19440	11/12/92	WO	B29C 49/00 x
SK	BE	0745395	4/12/96	EP	A61L 29/00 x
OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)					
SK	CA	Amoco product literature on PEN materials, pp. 3-5. Date unknown.			
	CB	M. Cakmak et al., Processing Characteristics, Structure Development, and Properties of Uni and Biaxially Stretched Poly(Ethylene 2,6 Naphthalene) PEN Films, <i>Polymer Engineering and Science</i> , vol. 30, no. 12, pp. 721-733, 1990.			
SK	CC	Teijin Polyethylene Naphthalate Resin Technical Information. Predates 9/14/95.			
EXAMINER <i>S Kennedy</i>		DATE CONSIDERED 6/21/04			
EXAMINER: Initial citation considered. Draw line through citation if not in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.					



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LIST OF PATENTS AND PUBLICATIONS FOR APPLICANT'S INFORMATION DISCLOSURE STATEMENT (Use several sheets if necessary)		APPLICANT: DAVID A. FERRERA ET AL					
		FILING DATE: Not Assigned			GROUP: Not Assigned		
REFERENCE DESIGNATION		U.S. PATENT DOCUMENTS					
EXAM'S INIT.		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
	AA						
	AB						
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						
	AL						
FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES NO
SK	BA	0 747 070	12/11/96	EP			X
SK	BB	0 768 097	4/16/97	EP			X
SK	BC	96/00752	1/11/96	WO			X
	BD						
	BE						
OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)							
SK	CA	JAPANESE ABSTRACT, APPLN NO. 03174200, FILED 7/15/91					
SK	CB	JAPANESE ABSTRACT, APPLN NO. 05088654, FILED 4/15/93					
	CC						
EXAMINER		SKennedy			DATE CONSIDERED 6/21/04		
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FORM PTO-1449 (Modified) INFORMATION DISCLOSURE STATEMENT BY APPLICANT (Use several sheets if necessary)				ATTY DOCKET NO.: S63.2-6259-US03		SERIAL NO.: 10/600017	
				APPLICANT: David A. Ferrera et al			
				FILING DATE: Not Assigned		GROUP: Not Assigned	
REFERENCE DESIGNATION				U.S. PATENT DOCUMENTS			
EXAM'S INIT.		PATENT NUMBER	ISSUE DATE	PATENTEE	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
SK	AA	5223205	6/29/93	Jackowski et al.	264	521	
	AB	4820349	4/11/89	Saab	128	344	
	AC	5492741	2/20/96	Akao et al.	428	35.2	
	AD	5348538	9/20/94	Wang et al.	604	96	
	AE	5403340	4/4/95	Wang et al.	606	194	
	AF	5449820	9/12/95	Fukui et al.	562	486	
	AG	5189140	2/23/93	Nakane et al.	528	272	
	AH	5,587,125	12/24/96	Roychowdhury	264	515	
	AI	5500181	3/19/96	Wang et al.	264	532	
SK	AJ	5330428	7/19/94	Wang et al.	604	96	
FOREIGN PATENT DOCUMENT OR PUBLISHED FOREIGN PATENT APPLICATION							
		DOCUMENT NUMBER	PUBLICATION DATE	COUNTRY OF PATENT OFFICE	CLASS	SUBCLASS	TRANSLATION YES NO
	BA						
	BB						
	BC						
OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)							
SK	CA	D. Callander and E. Sisson, High Performance PEN & Naphthalate Based Packaging Resins, Shell Chemical Co., April 1994.					
SK	CB	D2857-70 Standard Method of Test for Dilute-Solution Viscosity of Polymers, 1970 Annual Book of ASTM Standards, Part 27, Plastics-General Method of Testing, Nomenclature, pp. 713-718.					
	CC						
	CD						
	CE						
EXAMINER <i>S Kennedy</i>				DATE CONSIDERED <i>6/21/04</i>			
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FORM PTO-1449 (Modified) LIST OF PATENTS AND PUBLICATIONS FOR APPLICANT'S INFORMATION DISCLOSURE STATEMENT (Use several sheets if necessary)		ATTY DOCKET NO.: S63.2- 6259-US03		APPLICATION NO.: 10/600017		
		APPLICANT: David A. Ferrera et al.				
		FILING DATE: Not Assigned		GROUP: NA		
REFERENCE DESIGNATION U.S. PATENT AND PUBLISHED APPLICATION DOCUMENTS						
EXAM'S INIT.		DOCUMENT NUMBER	DATE	NAME	CLASS/ SUBCLASS	FILING DATE IF APPROPRIATE
SK	AA	5879369	3/9/99	Ishida	606/194	
	AB	6242063	6/5/01	Ferrera et al.	428/35.2	
	AC	5554120	9/10/96	Chen	604/96	
	AD	5304340	4/19/94	Downey	264/521	
	AE	6004289	12/21/99	Saab	604/96	
	AF	6013728	1/11/00	Chen et al.	525/92	
	AG	5871468	2/16/99	Kramer et al.	604/96	
	AH	6013055	1/11/00	Barnpos et al.	604/27	
	AI	6325780	12/4/01	Schaible et al.	604/103.06	
SK	AL	6358227	3/19/02	Ferrera et al.	604/103.06	
FOREIGN PATENT DOCUMENTS						
		DOCUMENT NUMBER	DATE	COUNTRY		
	BA					
OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)						
SK	CA		JP abstract of patent number 2509016; publication number 05-15603.			
SK	CB		JP abstract of patent number 2975803; publication number 06/296693.			
EXAMINER		DATE CONSIDERED				
SK Kennedy		6/21/04				
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